

# Flexible Displays and Microelectronics: *Opportunities and Challenges*

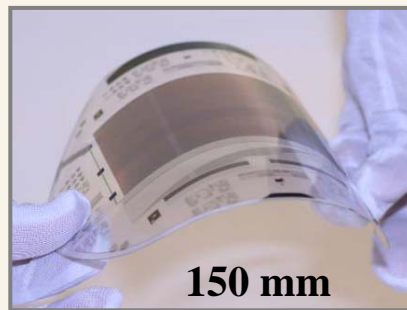
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<http://flexdisplay.asu.edu>

# Outline

- Flexible Displays and other “MacroTechnology” Opportunities
- Principal Technology Challenges
  - Manufacturing Processes
  - Device Performance
  - Materials
- Product Pull vs. Technology Push
- Conclusions



# Emerging MacroTechnology: *Flexible Displays*

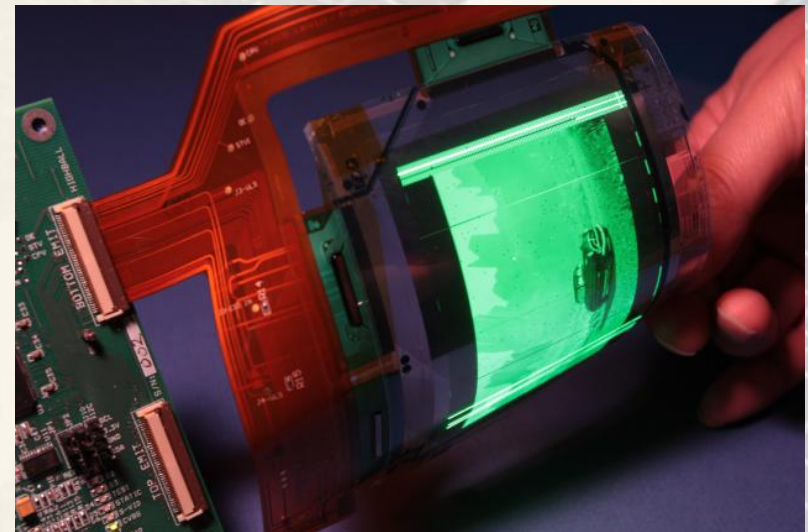
## **Reflective** **Electrophoretic Displays**

- Ultra-low power
- Sunlight readable
- Near-video rates



## **Emissive** **Organic Light Emitting Displays**

- Low power
- Vibrant full color
- Full motion video



**GENERAL DYNAMICS**  
Strength on Your Side™

Source: Flexible Display Center  
at Arizona State University  
<http://flexdisplay.asu.edu>

*AVS Thin Film Users Group Meeting August '09*



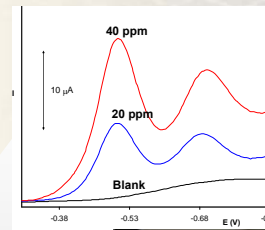
# Flexible Electronics as the Enabling Platform Technology

Integrate flexible TFT backplanes with frontplanes of different functionality to create new technology

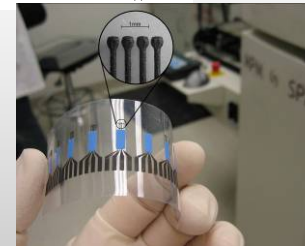
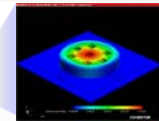
## Image-layer Frontplane Flexible Displays



## Sensing-layer Frontplane Flexible Sensor Arrays



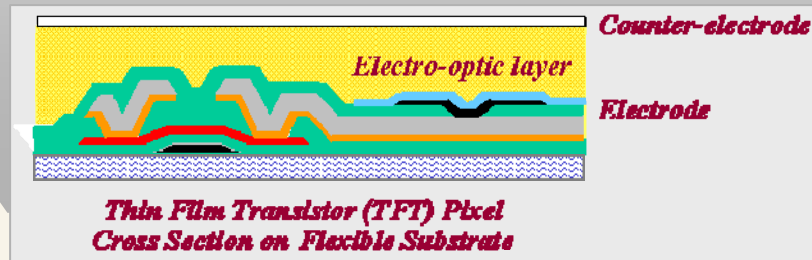
### Flexible Blast Dosimeters



Sensors for Environmental Threat Detection and Human Health/Performance Monitoring  
Images compliments of J. Wang ASU BDI



Flexible Digital Radiography

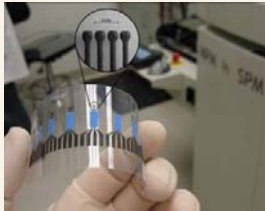


# Transformational Positioning

**Macrotechnology** → does not compete / replace Si-based devices -- instead complements in applications where Si CMOS is not well-suited (new products, applications and markets)

## Macrotechnology Unique Attributes:

- **Less is not Moore!** → not driven by transistor down-scaling (performance), instead driven by unique integrated functionality and form factor
- **Bigger is Better!** → large area (as well as small) applications
- **Be Flexible!** → compact, ultra-thin, rugged, lightweight, implantable, wearable, conformable, and (potentially) transparent



Sensors



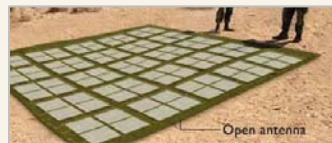
Inflatable spacecraft and extra-terrestrial habitats



Wearable Devices



Flexible Digital Radiography



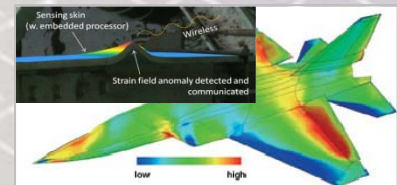
Foldable Large Area Antenna



Flexible Solar Cell



Building-integrated PV and SSL



Smart Skins for Structural Health Monitoring

# Key Manufacturing Challenges

3

Robust materials with manufacturable processes on flexible backplanes

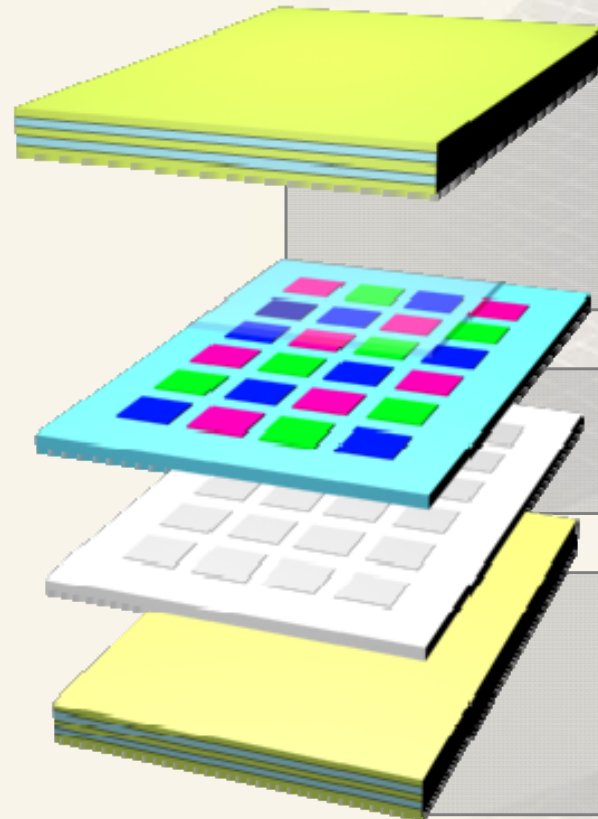
2

Manufacturable high quality TFT materials within substrate constraints

1

Manufacturing-ready substrates: no “drop-in” replacement for glass

Method for handling flexible substrates in display-scale automated manufacturing equipment



Encapsulated EO Materials and Devices

Backplane Electronics

Impermeable Flexible Substrates

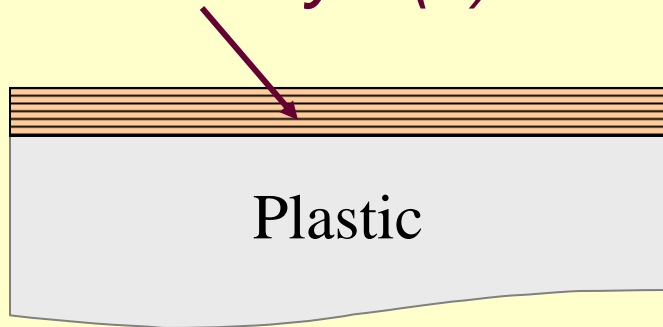
***Encapsulated Electro-optic (EO) Devices integrated with an Active Matrix Backplane fabricated on a Flexible Substrate System***

# Flexible Substrate Systems: *Down-selects and Challenges*

*No manufacturing-ready “drop-in” replacements for glass*

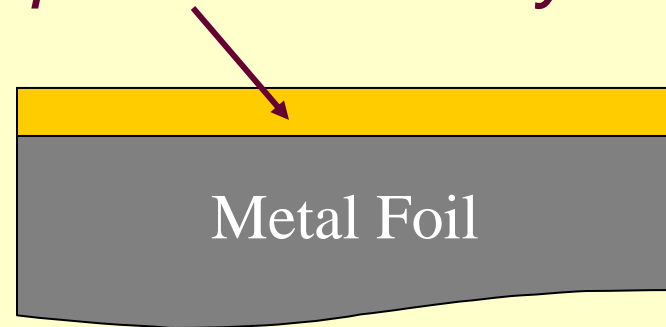
## *Plastic (PEN, PES, PI)*

- Process T limit
- Dimensional stability
- Permeable to O<sub>2</sub>/H<sub>2</sub>O:  
*barrier layer(s)*



## *Metal Foil (SS)*

- Limited flexibility
- Stress management
- Surface passivation:  
*planarization layer*



# Parallel Manufacturing Pathways

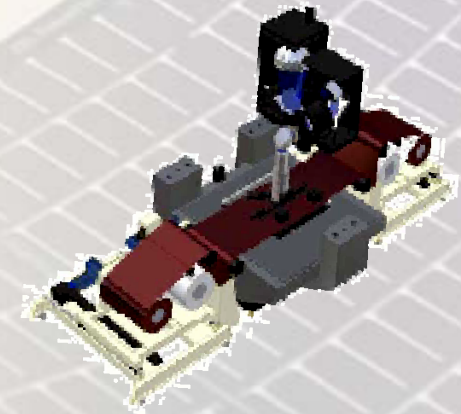
- Adapt existing plate-to-plate toolset infrastructure

- ❌ Free-standing flexible substrates
- ❌ Substrate fixturing / framing
- ❌ Backside thinning: chemical etch or grind-polish
- ✅ Substrate temporary bonding – debonding
- ✅ Substrate coat - release
- ✅ Layer transfer



- Adopt Roll-to-Roll manufacturing infrastructure

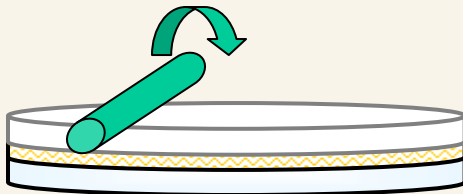
- ❌ Toolsets immature with significant issues – handling, layer alignment, resolution, reliability
- ❌ Metrology strategy undefined
- ✅ Take step-wise “R2R-compatible” approach focusing on critical issues





# Manufacturing Protocol Options

**Bond - Debond**  
FDC SEC LG-D ITRI PV



Substrate bonded with  
Temporary Adhesive  
to Carrier

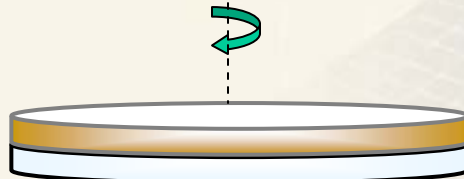


TFT Fabrication  
130 - 180 °C



*Triggered Debond:*  
Thermal  
Solvent  
Light  
Mechanical

**Coat - Laser Release**  
IBM Philips (EPLAR) PVI



Spin-coated Polyimide  
on Carrier



TFT Fabrication  
280 - 300 °C



*Laser Release:*  
Interfacial Melting

**Layer Transfer**  
Seiko-Epson (SUFTLA)



Sacrificial poly-Si  
on Carrier



TFT Fabrication  
300 - 380 °C



Temporary Substrate bonded  
with Water-soluble Adhesive



*Laser Release: Ablation*



Bond to Flex then release

# Capability/Limitation Comparison

Capability/Limitation	Temp Bonding	EPLaR	SUFTLA
Flexible Substrate	<u>High surface quality</u> polymer or metal foil	Solution-castable polymers (PI, BCB)	Any
TFT Process Temperature Limit	Substrate-dependent (180 °C for HS-PEN)	Polymer-dependent (280 °C for PI)	Typical glass-based TFT limits
Flexible Substrate Distortion	Can be significant – <i>but can be controlled to negligible level !</i>	Negligible	Not applicable
Release Process	Rapid automated dry	Laser interfacial melting	Laser ablation
Scale-ability	?	?	?

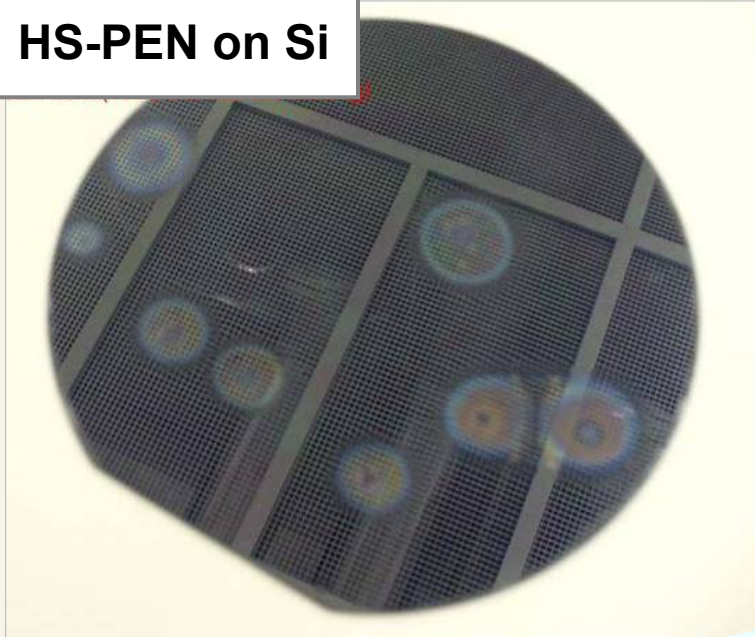
# Temporary Bonding – Debonding: *Manufacturing Challenges*

- Temporary bonding **with semiconductor-grade adhesive** (developed by Henkel with FTA funding and FDC pilot line development)
  - ✓ Compatible with Si-based TFTs
  - ✓ Low total thickness variation (TTV)
  - ✓ Defect (particle/bubble) free
  - ✓ TFT and EO process flow and toolset compatible
- Automated de-bonding
  - ✓ Triggered release (thermal, radiation, chemical, mechanical)
  - ✓ Residue-free
  - ✓ TFT array and substrate (and carrier) damage-free

*Complexity of component interactions requires system-level substrate/barrier/adhesive/carrier/toolset solution*

# Temporary Bonding Pitfalls

HS-PEN on Si



Blisters form at defect  
(bubble, particles) sites

Exacerbated by  
adhesive out-gassing at  
temperature and in  
vacuum

SS on Si



“Teacup” failure due to  
CTE mismatch between  
substrate and carrier

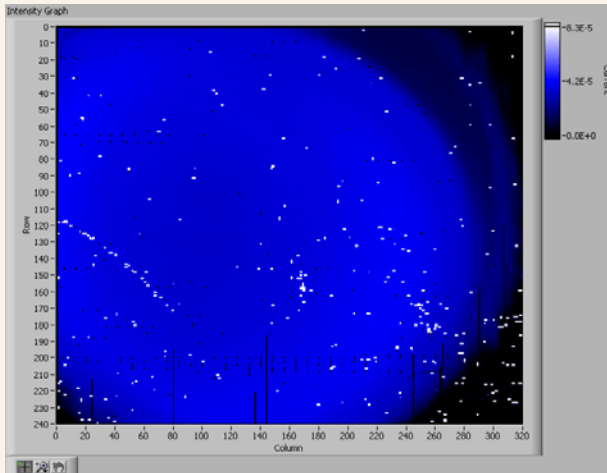
Adhesive visco-  
elasticity also crucial

# Effect of Bow on TFT Array Quality

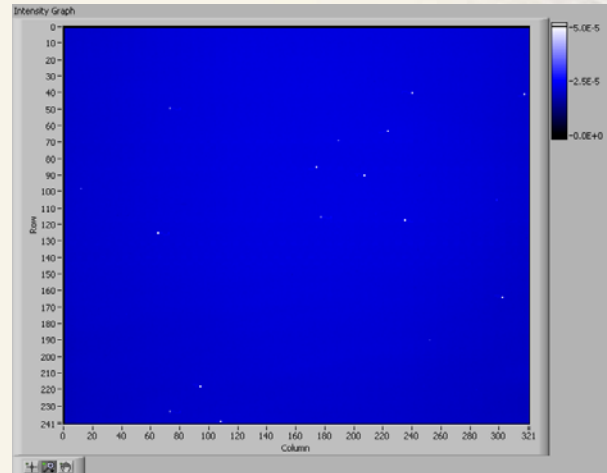
## *SS Substrates*

### TFT Drive Current Array Maps

**3.8-in. QVGA EPD  
Display Module**



**Original Materials  
and Process**



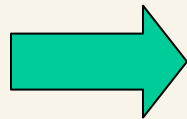
**New Materials  
and Process**



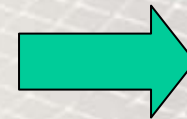
**Low (*Pilot Line*)  
defectivity**  
**<0.01% point defects**  
**0-3 line defects**

# Low Temperature a-Si:H TFT Process Challenges and Approach

Glass-based TFTs  
300-350 °C. Process  
Temperatures



TFTs on Flex  
180 °C. Process  
Temperature



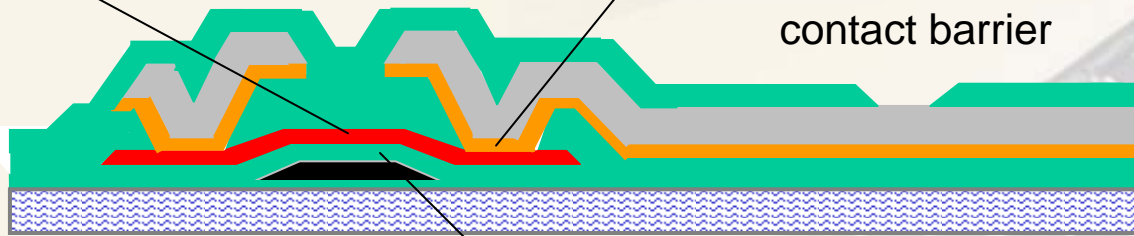
Lower quality  
active device  
materials

a-Si:H

- ✗ higher SiH<sub>2</sub>/SiH ratio → higher V<sub>t</sub> and lower μ<sub>sat</sub>

n<sup>+</sup> a-Si:H contacts

- ✗ unactivated dopants → higher ρ
- ✗ Unstable interface → contact barrier



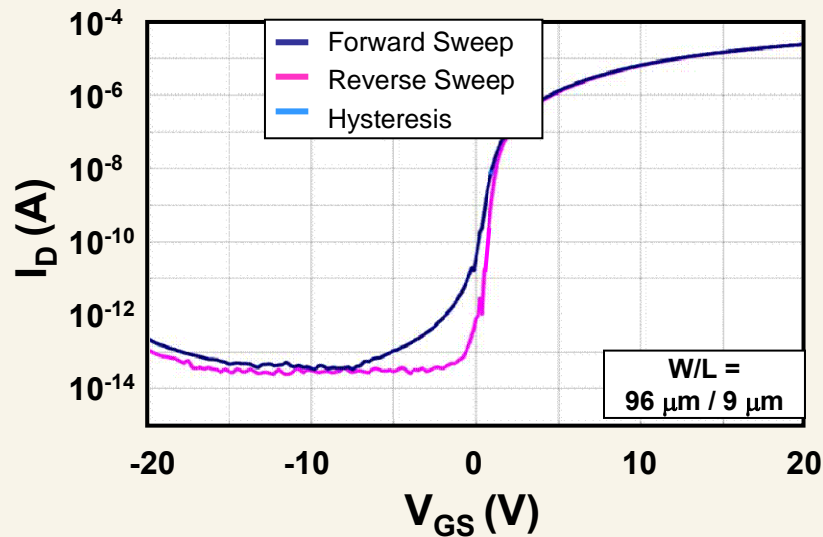
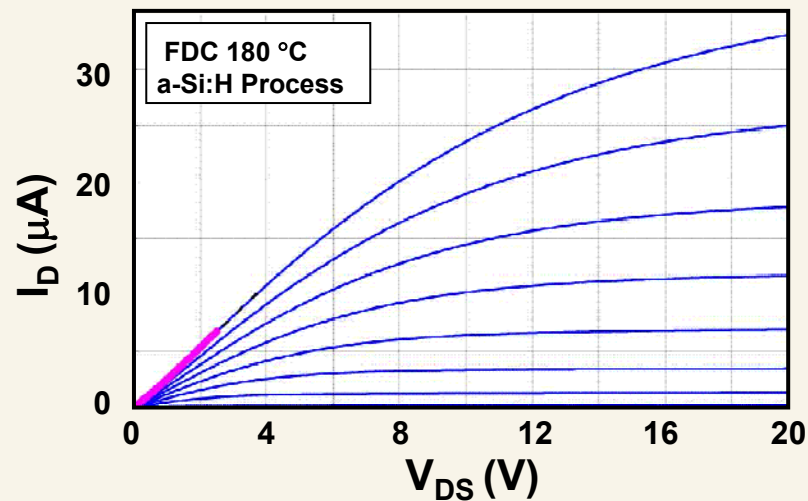
Identify new process windows to achieve equivalent or better performance

a-SiN<sub>x</sub>:H  
gate dielectric

- ✗ higher charge trap density → greater ΔV<sub>t</sub> (stability degradation) and greater hysteresis



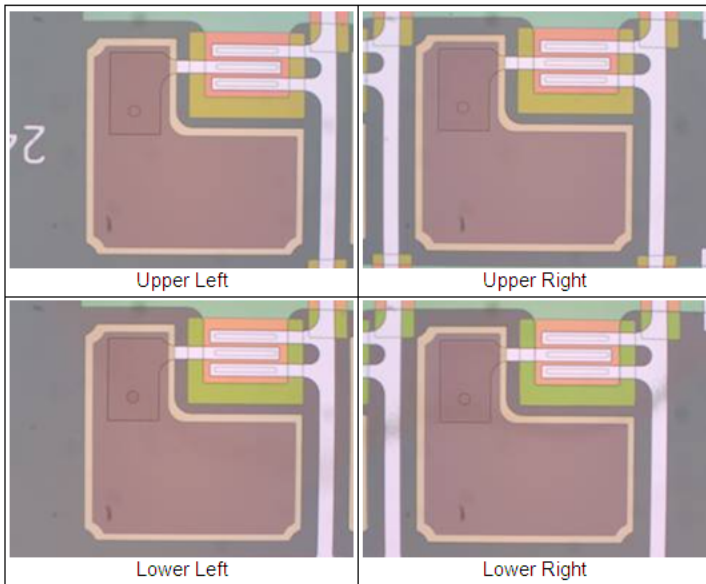
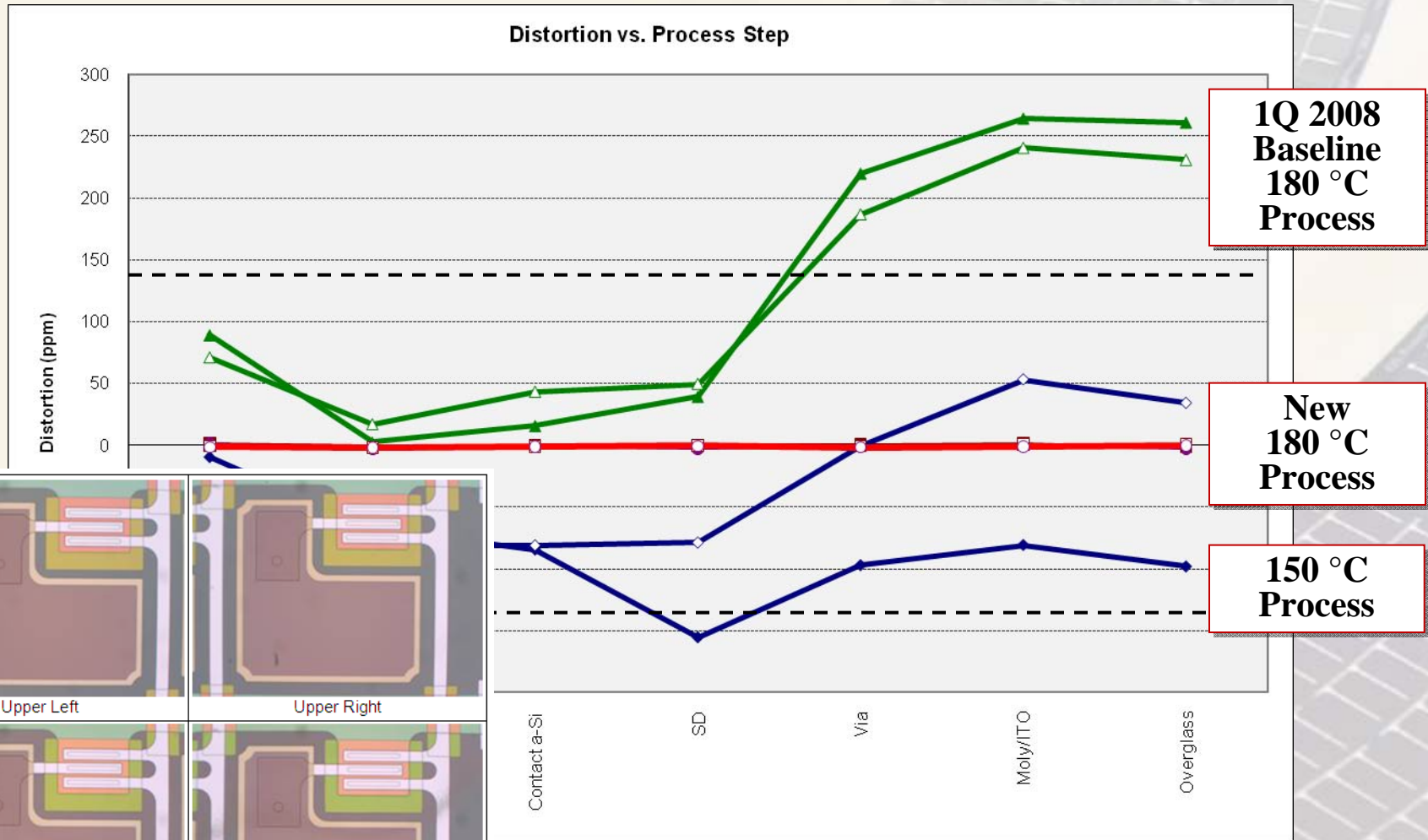
# FDC 180 °C a-Si:H TFT Performance



Parameter	FDC	SEC <sup>1</sup>	
Max. Process Temperature	180 °C (flex)	130 °C (flex)	370 °C (glass)
Saturation Mobility (cm <sup>2</sup> /V-s)	0.8	0.5	0.5
ON/OFF Ratio	2 x 10 <sup>9</sup>	1 x 10 <sup>8</sup>	4 x 10 <sup>7</sup>
Drive Current (μA)	30	1.2	4.0
Threshold Voltage (V)	1.0	4.5	0.7

<sup>1</sup> P. Shin, USDC Flexible Displays Conference (2007)

# Plastic Processing Breakthrough: *Zero-distortion Process*



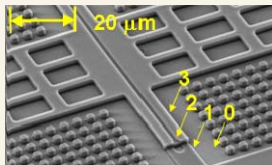
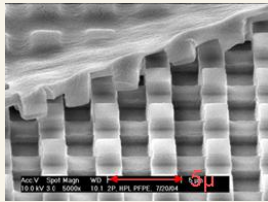
**TFT pixels at 4 corners of 3.8-in QVGA**



# HP Self-Aligned Imprint Lithography

*Circumvents Distortion Issue*  
*Large Area Nano-device Scaleable?*

## Imprint Lithography: Photomask-free Process



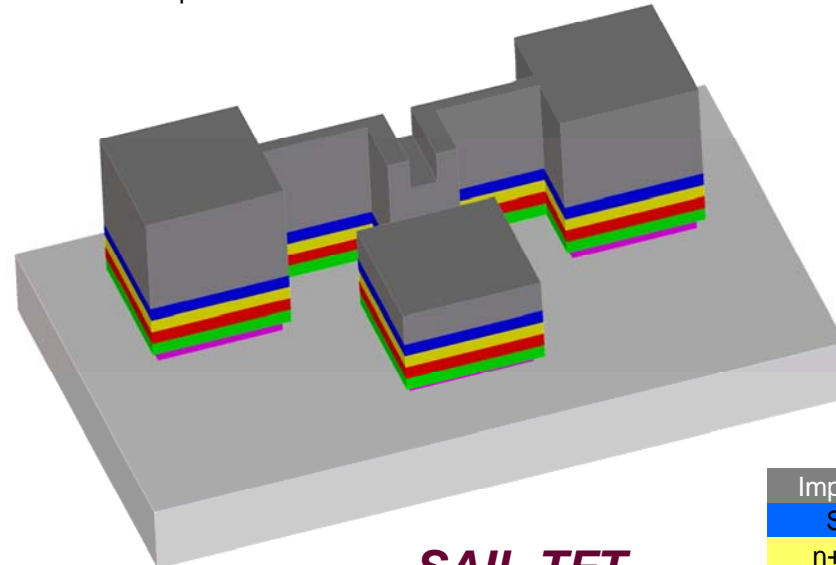
4 levels in 0.5 μm steps →

Multiple mask levels

Imprinted as single 3D structure

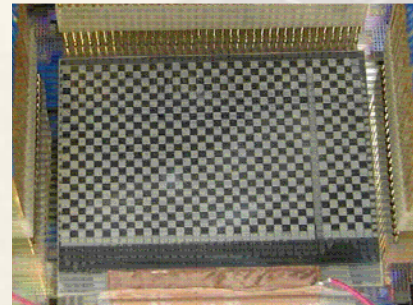
O. Kwon, et al., IMID 2007, Daegu, ROK  
 Compliments of Carl Taussig

Then undercut to remove from  
under thinnest parts of mask



## SAIL TFT Etching Process

- Imprint polymer
- S&D metal
- n+ Si contact
- a-Si:H channel
- SiNx dielectric
- Gate metal
- Plastic substrate



HP SAIL-fabricated AM-EPD  
on FDC thin film stack on HS-PEN

# Path to Reliable Higher Performance *Advanced TFT Technology*

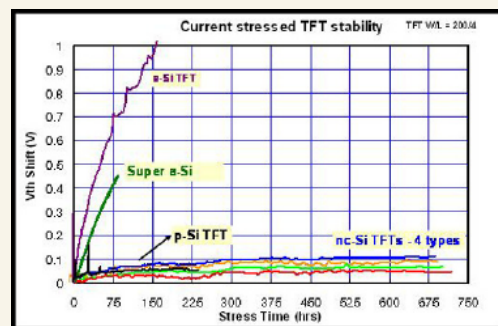
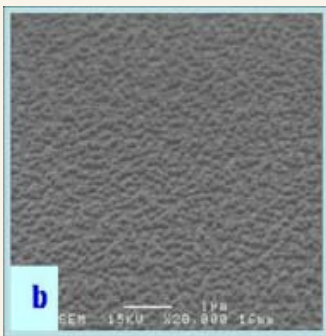
## **CHALLENGE:**

- *a-Si:H* inherently unstable in current-driven devices
- *poly-Si* a costly solution on glass and problematic on flex
- Organic TFTs unsuitable: poor performance and instability
- CNTs a longer-range opportunity: purity and manufacturability

## **APPROACH:**

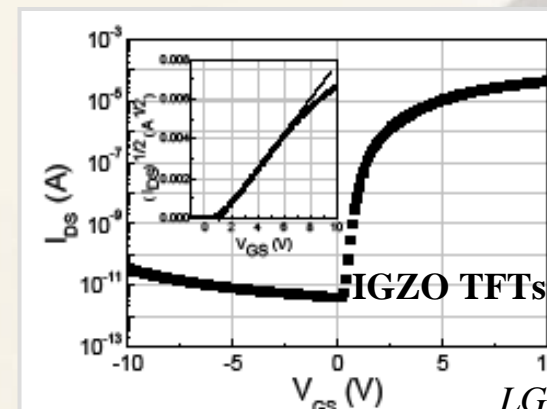
Seek stable high performance TFT technologies  
compatible with existing *a-Si:H* manufacturing infrastructure

### *Nanocrystalline Si (nc-Si)*



Samsung Electronics, JSID 15/2, 113-118 (2007)

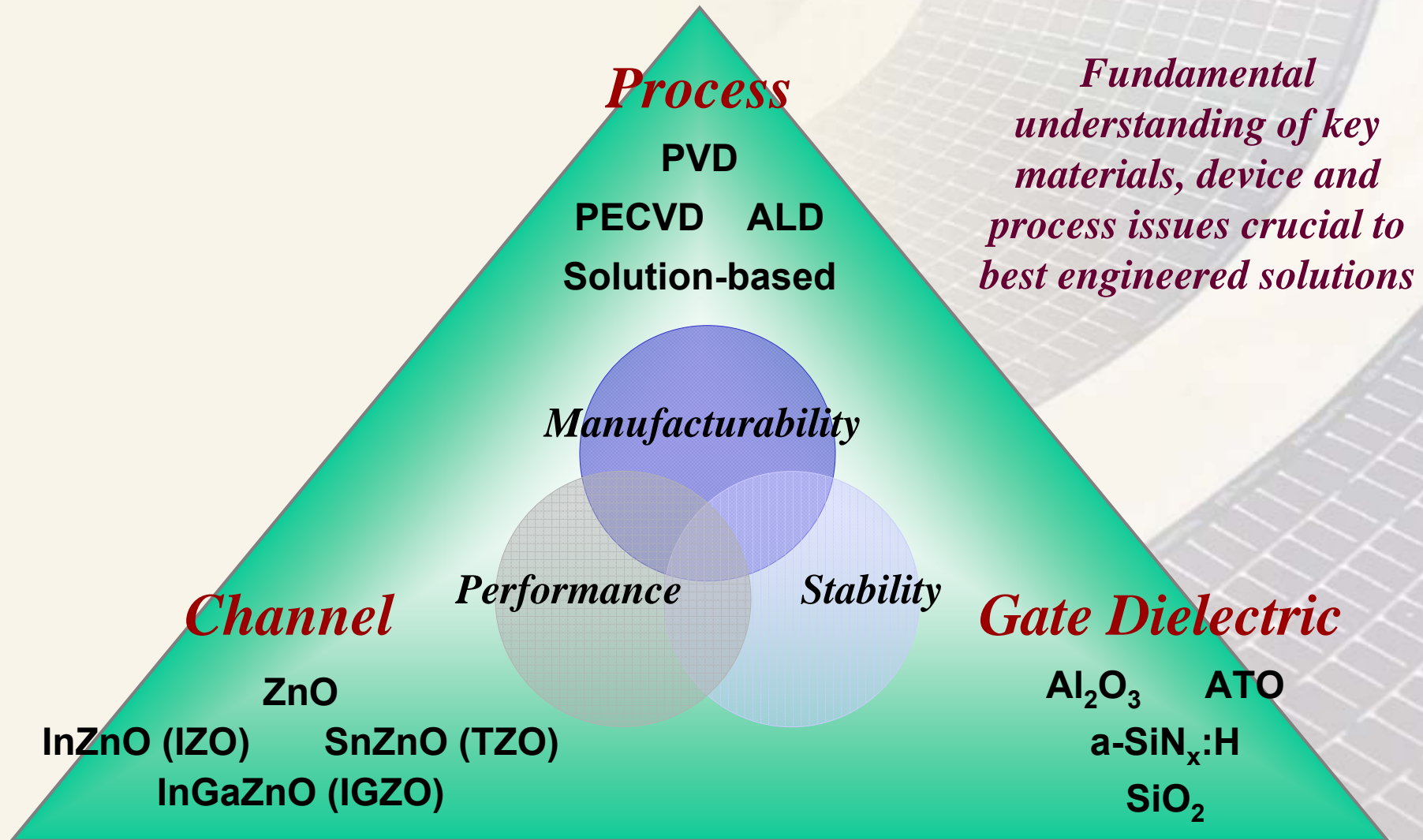
### *Metal Oxides*



3.5-in qCIF+

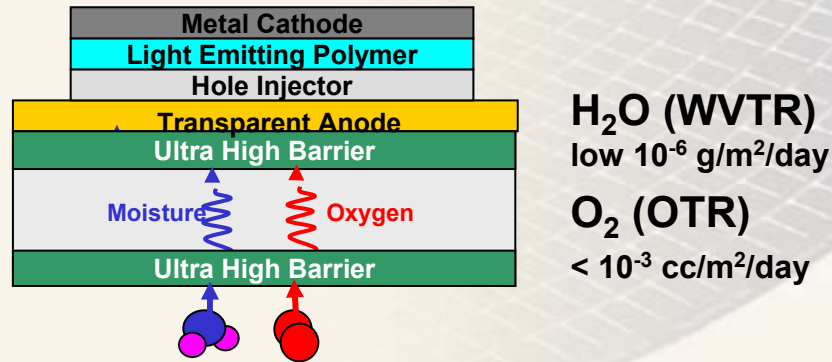
LG Electronics, SID 2007

# (Some) Oxide TFT Options

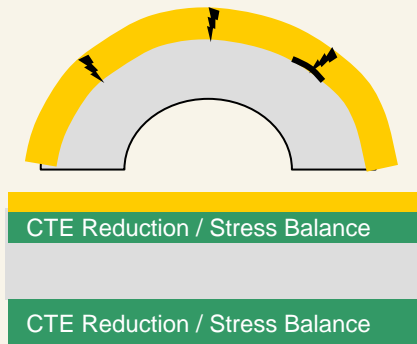


# Barrier/Encapsulation Requirements

## Moisture/Oxygen Permeability (Transmission Rate)

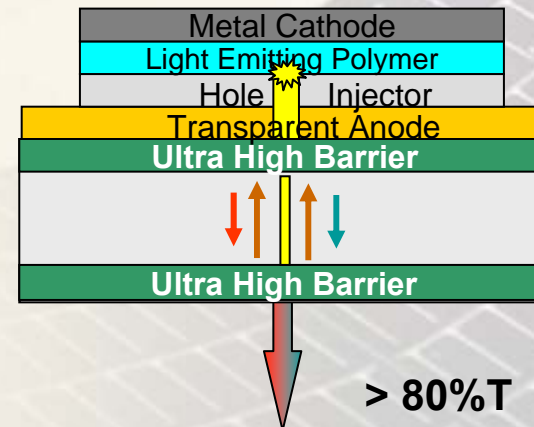


## Thermo-mechanical stability



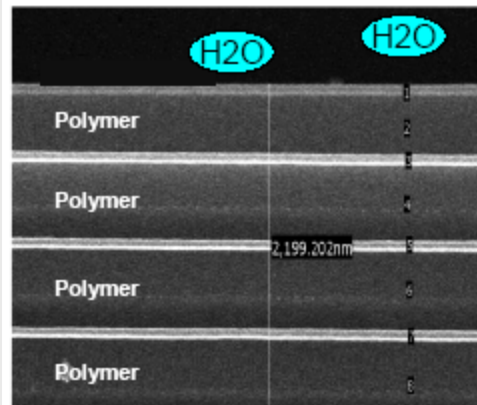
**Shrinkage**  
 $< 20$  ppm/hr @150°C  
**Bending**  
 diameter  $\leq 1''$   
**Adhesion**  
 $\geq 4B$

## Optical Transmission



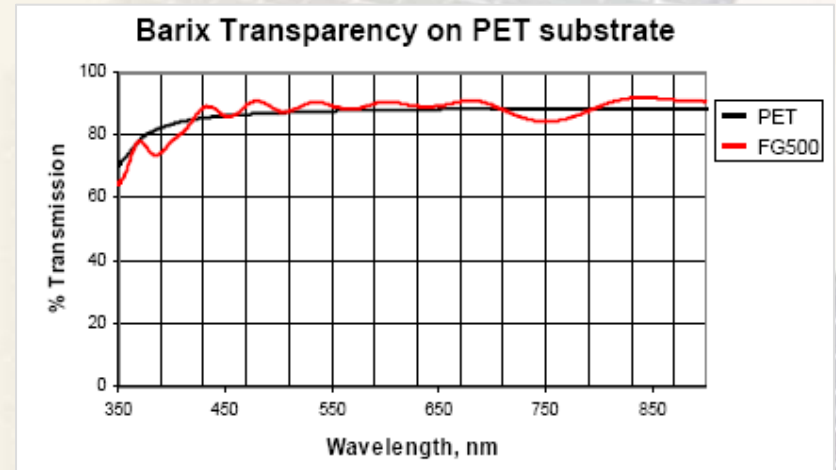
Courtesy of GE Global Research

# Vitex Multilayer Barix™ Approach

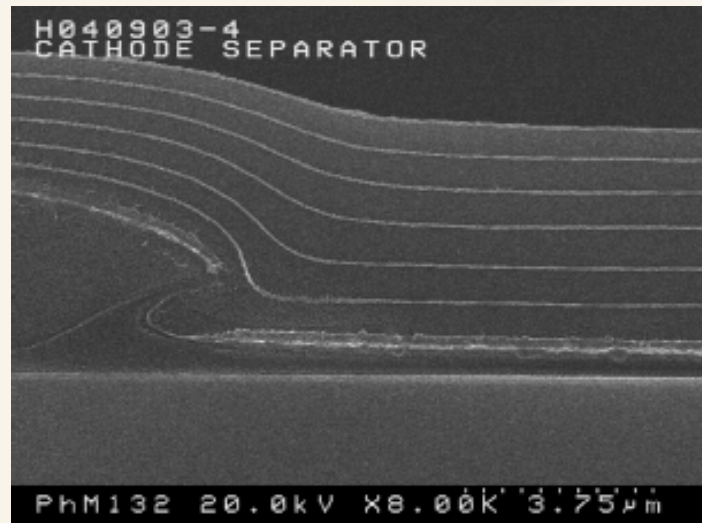


**Inorganic barrier layers**

**3-7 diads (polymer-inorganic pairs)**



**Polymer layers provide planarization and conformal coverage of defects**



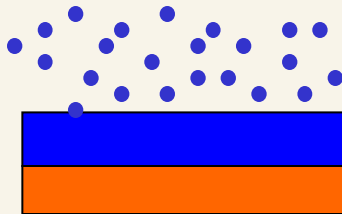
*Effectiveness of multi-layer approach attributed to isolation of defects and enhanced diffusion length*



# Direct Observation of Water Distribution in Barrier Films

## X-ray Reflectivity (XR)

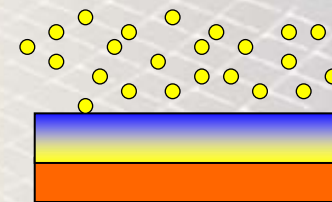
Water 'looks' like polymer  
(similar density)



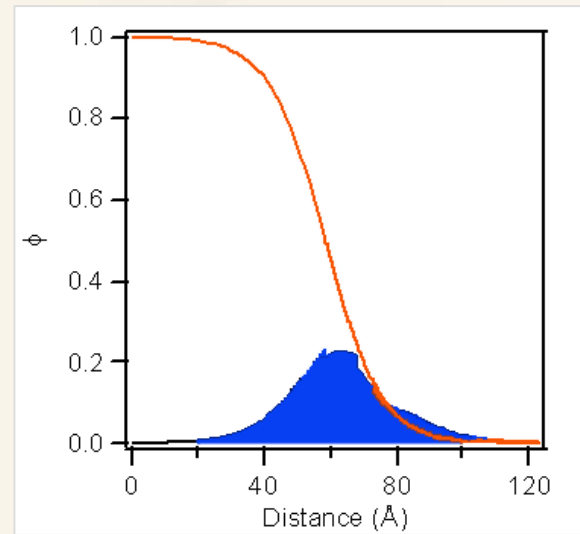
- Measure thickness change due to moisture absorption
- Mass density profile
- Estimate permeation rate

## Neutron Reflectivity (NR)

Water visible  
(Heavy water)



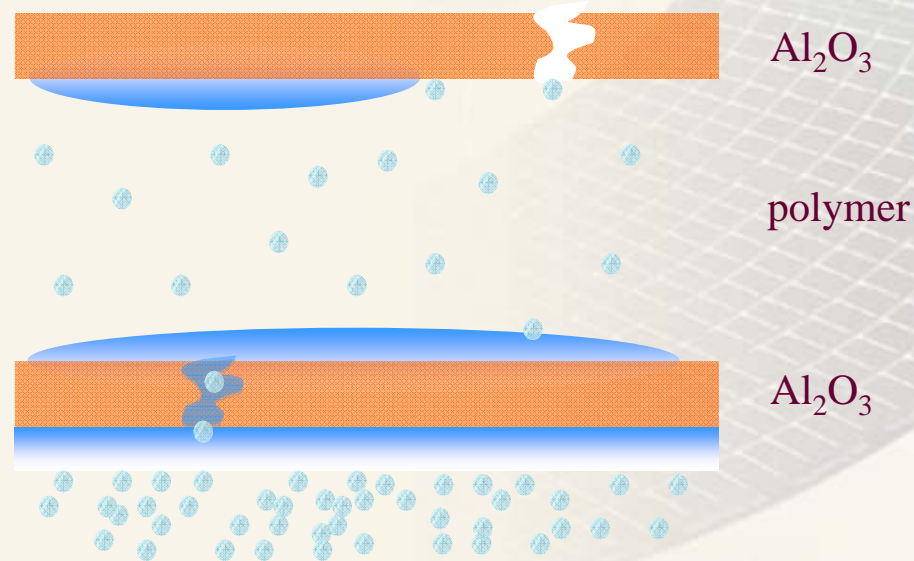
- Isotopic sensitivity ( $^1\text{H}$  vs.  $^2\text{H}$ )
- Measure water distribution within film



**Water  
concentrated at  
interface**

Vogt *et al.*, *J. Appl. Phys.* **97**, 114509 (2005)

# Proposed Mechanism for H<sub>2</sub>O Transport



- Moisture permeation is dominated by defects
- Water transport retarded by oxide/polymer interface
  - Water adsorbs at interface
  - Internal desiccant effect
- Leads to long lag times
- Equilibrium behavior not important if lag time > lifetime
- **Potential paradigm shift in design of nanao-engineered barriers**

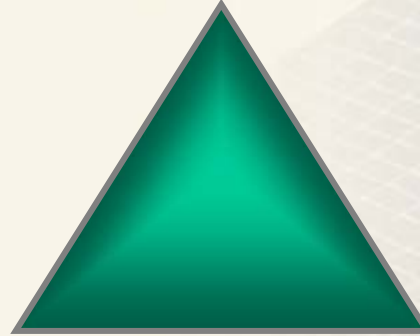
Vogt *et al.*, *J. Appl. Phys.* **97**, 114509 (2005)

*AVS Thin Film Users Group Meeting August '09*



# Transparent Conductors: *ITO replacement*

Flexibility

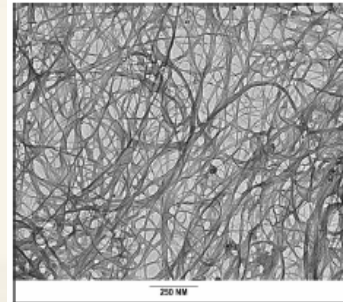


< 40 Ohm/ sq **Conductivity**

**Transparency** > 90 %T

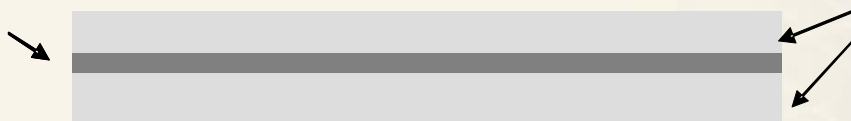
## **Options**

- ✓ Conductive polymers
- ✓ CNT films
- ✓ IMI composites



TEM of  
CNT Film  
Source: Eikos

Silver



Dielectric

ITO  
TiO<sub>2</sub>  
Nb<sub>2</sub>O<sub>5</sub> ...



# Product Pull vs. Technology Push

iNEMI Flexible Electronics Roadmap 2009 listed  
“slow pace of product development”  
as a “showstopper” !

Recent NSF and ONR co-funded  
Working Group commissioned to assess the global  
competition in Flexible Electronics recommended  
establishment of application-driven center-level efforts  
in the U.S.

# Center for Ubiquitous MacroTechnology (CUbiq-M)

*An NSF Engineering  
Research Center Concept*

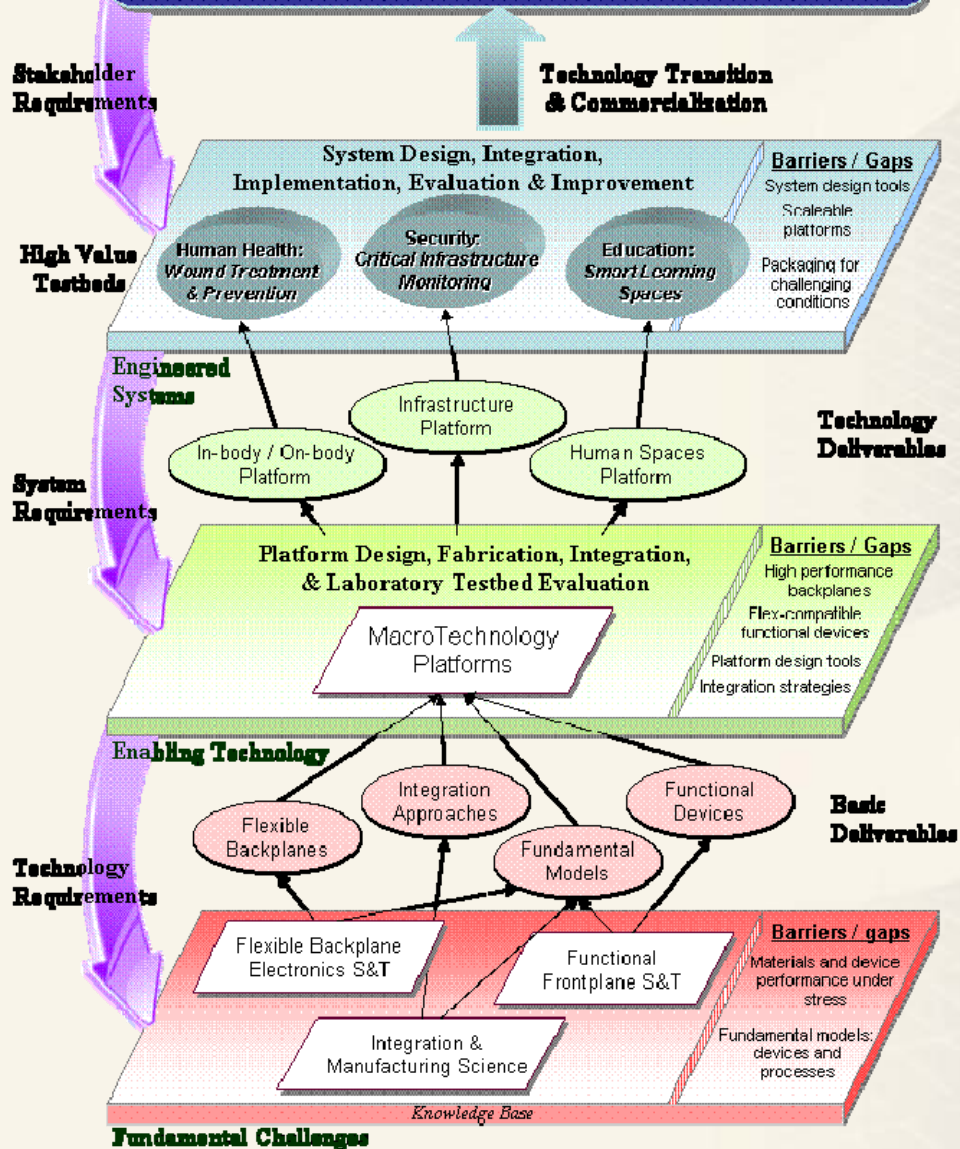


東京大学  
THE UNIVERSITY OF TOKYO

# Vision

*The Center for Ubiquitous MacroTechnology* will demonstrate large-area flexible electronics (MacroTechnology) as a transformative tool for a broad range of new high-value applications and industries. The worldwide electronics industry has generated tremendous economic and societal impact despite severe design limitations: with few exceptions, electronic products are small, rigid, fragile, opaque and incompatible with living tissue. *CUbiq-M* proposes engineered systems-driven research to liberate electronics from these arbitrary constraints. *CUbiq-M's* vision is that a new wave of ultra-thin, lightweight, flexible, conformable, rugged, biocompatible, self-healing and transparent MacroTechnology products will provide transformative solutions for critical national problems in healthcare, safety, security, sustainability and beyond. These new products will catalyze economic growth and global competitiveness.

Toward Ubiquitous MacroTechnology for  
Human Health, Safety, Security,  
Performance, Education and Beyond



# ERC Strategic Plan Design

# Exemplary Technology Demonstrations

## Wound Care / Avoidance

### “Smart” Bandages and Implantable Films

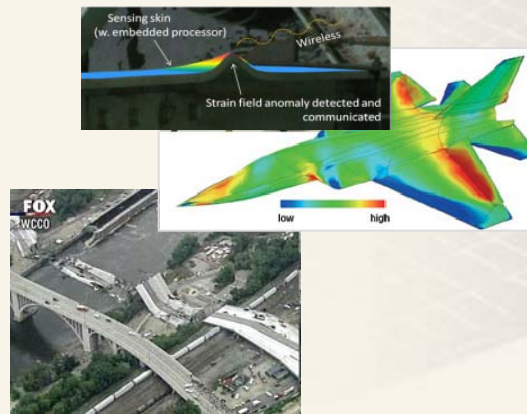
- *Electronic stimulation*
- *Diagnostic sensors*
- *Controlled drug release*
- *Wireless interrogation*
- *Self-powered*



## Critical Infrastructure Monitoring

### Smart Conformable Skins

- *Strain field sensing arrays*
- *Visual read-out / indicators*
- *Wireless interrogation*
- *Internal or external surfaces*



## Smart Spaces / Buildings

### Enabling Technologies

- *Large area building-integrated PV/SSL*
- *Surface-embedded unobtrusive sensor net*  
+ *human activity (security and health)*  
+ *environmental conditions (health)*
- *Actuator-control and decision systems*
- *Surface-embedded “edge-to-edge” HCIs*



*Demonstration I:  
In-body/on-body  
for Human Health*

*Demonstration II:  
Infrastructure-  
integrated for  
Security / Safety*

*Demonstration III:  
Building-integrated  
for Human  
Performance*

**Engineered  
Systems**

*Biosensing & drug delivery  
Stretchable / compliant  
Biocompatible / soft  
Small area*

*Mech sensing & actuation  
Low deformation / rollable  
Rugged / durable  
Small to human-scale area*

*Sensing – human interfaces  
Conformable / “seamless”  
Surface-durable / stable  
Small to large area*

# Summary

- **Flexible Displays and MacroTechnology hold great promise for new products of unique form, fit and function for military, health, security, energy and the environment, and space applications**
- **Opportunities for breakthroughs and advances**
  - ✓ **Manufacturing processes**
  - ✓ **Devices (TFT backplanes and functional frontplanes)**
  - ✓ **Materials**
- **Specific Challenges and Gaps**
  - ✓ **Scale-ability → scaling laws, limitations and tradeoffs**
  - ✓ **Stable high performance TFT technology for OLEDs and beyond**
  - ✓ **High performance low cost flexible barrier / encapsulation technology**
  - ✓ ***Product focus as the technology driver***

# For Further Information

## Flexible Display Center

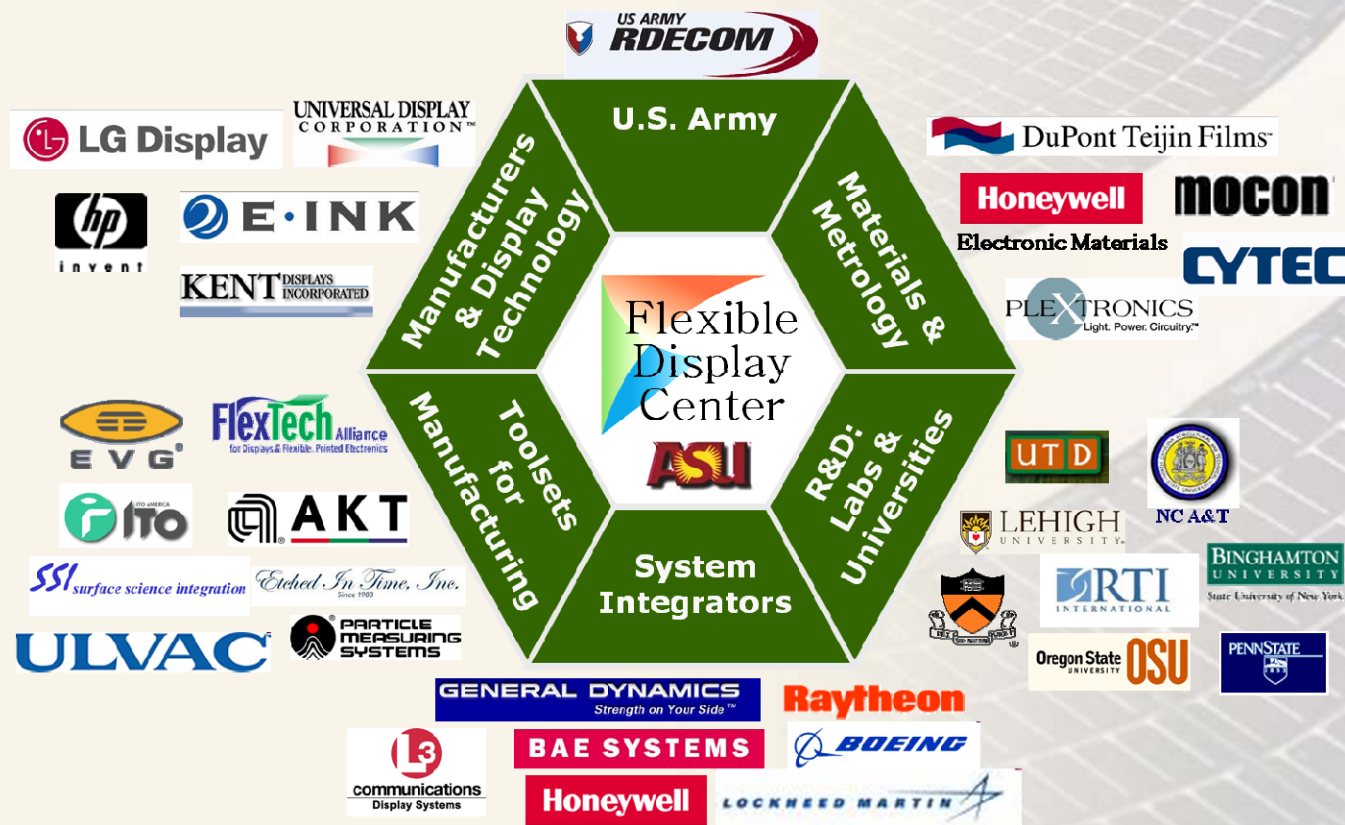
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# Thanks to the FDC Team



*AVS Thin Film Users Group Meeting August '09*



***Thank You !***